

**Notice of References Cited**

Application/Control No.

09/706,814

Applicant(s)/Patent Under  
Reexamination  
CHUN, KANG-WOOK

Examiner

JAMIE JO VENT ATALA

Art Unit

2621

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,754,239	06-2004	Negishi et al.	370/537
*	B	US-6,404,776	06-2002	Voois et al.	370/468
*	C	US-6,052,507	04-2000	Niida et al.	386/68
*	D	US-6,888,125	05-2005	Ronnekleiv et al.	250/227.19
*	E	US-7,096,488	08-2006	Zhang et al.	725/105
*	F	US-6,091,772	07-2000	Anderson et al.	375/240.26
*	G	US-5,838,873	11-1998	Blatter et al.	386/95
*	H	US-7,027,718	04-2006	Ohishi et al.	386/98
*	I	US-7,095,948	08-2006	Teunissen, Cornelis	386/68
*	J	US-6,011,899	01-2000	Ohishi et al.	386/98
*	K	US-6,574,347	06-2003	Linse, Jason N.	381/431
*	L	US-6,779,195	08-2004	Oishi et al.	725/68
*	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	W					
	X					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.